Search Notes	

Application/Control No.		Applicant(s)/Patent under Reexamination	
10/707,892		CHENG ET	AL.
Examiner		Art Unit	
Matthew C. La	andau	2815	

SEARCHED			
Class	Subclass	Date	Examiner
257	751,753, 737,738, E23.021, E23.16, E23.161	8/3/07	
	E23.16,	,	
	E23.161		Ψ
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INTERFERENCE SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
ENST Search (printout included)	8/3/07		
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